

### SVD830F-VB Datasheet

# N-Channel 650V (D-S) Power MOSFET

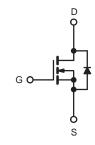
| PRODUCT SUMMA                              | RY                     |     |
|--|------------------------|-----|
| V <sub>DS</sub> (V) at T <sub>J</sub> max. | 650                    | )   |
| R <sub>DS(on)</sub> at 25 °C (Ω)           | V <sub>GS</sub> = 10 V | 1.1 |
| Q <sub>g</sub> max. (nC)                   | 25                     |     |
| Q <sub>gs</sub> (nC)                       | 2.0                    | )   |
| Q <sub>gd</sub> (nC)                       | 2.7                    | ,   |
| Configuration                              | Sing                   | le  |

#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial



N-Channel MOSFET

|  | G D S    |
|--|----------|
|  | Top View |
|  |          |

**TO-220 FULLPAK** 

| ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>        | = 25 °C, unl                 | ess otherwis                      | se noted)       |       |       |
|---|------------------------------|-----------------------------------|-----------------|-------|-------|
| PARAMETER                                       |                              |                                   | SYMBOL          | LIMIT | UNIT  |
| Drain-Source Voltage                            |                              | $V_{DS}$                          | 650             | V     |       |
| Gate-Source Voltage                             |                              |                                   | $V_{GS}$        | ± 30  | 7 v   |
| Continuous Drain Current (T,I = 150 °C)         | \/ at 10 \/                  | T <sub>C</sub> = 25 °C            |                 | 7.0   |       |
| Continuous Drain Current (1) = 150 C)           | $V_{GS}$ at 10 V $T_{C} = 1$ | T <sub>C</sub> = 100 °C           | I <sub>D</sub>  | 5.6   | A     |
| Pulsed Drain Current <sup>a</sup>               |                              |                                   | I <sub>DM</sub> | 28    |       |
| Linear Derating Factor                          |                              |                                   | 1.67/1.5/0.3    | W/°C  |       |
| Single Pulse Avalanche Energy b                 |                              | E <sub>AS</sub>                   | 86              | mJ    |       |
| Maximum Power Dissipation                       |                              | $P_{D}$                           | 83/83/31        | W     |       |
| perating Junction and Storage Temperature Range |                              | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150     | °C    |       |
| Drain-Source Voltage Slope                      | T <sub>J</sub> = 125 °C      |                                   | -1\//-14        | 50    | ) / / |
| Reverse Diode dV/dt <sup>d</sup>                |                              |                                   | dV/dt           | 4.5   | V/ns  |
| Soldering Recommendations (Peak Temperature) c  | for                          | 10 s                              |                 | 300   | °C    |

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=50$  V, starting  $T_J=25$  °C, L=28.2 mH,  $R_g=25$   $\Omega$ ,  $I_{AS}=3.5$  A.

- c. 1.6 mm from case. d.  $I_{SD} \le I_D$ , dl/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



| THERMAL RESISTANCE RATI          | NGS               |      |      |       |
|----------------------------------|-------------------|------|------|-------|
| PARAMETER                        | SYMBOL            | TYP. | MAX. | UNIT  |
| Maximum Junction-to-Ambient      | R <sub>thJA</sub> | -    | 63   | °C/W  |
| Maximum Junction-to-Case (Drain) | R <sub>thJC</sub> | -    | 0.6  | C/ VV |

| PARAMETER   | SYMBOL                | TEST CONDITIONS   |  | MIN. | TYP. | MAX.  | UNIT   |
|---|-----------------------|---|--|------|------|-------|--|
| Static  |                       |   |  | •    | l.   |       |  |
| Drain-Source Breakdown Voltage                            | V <sub>DS</sub>       | V <sub>GS</sub> =   | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA       |      | -    | -     | V  |
| V <sub>DS</sub> Temperature Coefficient                   | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = 1 mA                    | -    | 0.65 | -     | V/°C   |
| Gate-Source Threshold Voltage (N)                         | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA          | 2.5  | -    | 5     | V  |
|   |                       | ,   | V <sub>GS</sub> = ± 20 V                             | -    | -    | ± 100 | nA   |
| Gate-Source Leakage                                       | $I_{GSS}$             |   | $V_{GS} = \pm 30 \text{ V}$                          | -    | -    | ± 1   | μA   |
|   |                       |   | = 650 V, V <sub>GS</sub> = 0 V                       | -    | -    | 1     | <del>                                     </del> |
| Zero Gate Voltage Drain Current                           | $I_{DSS}$             |   | /, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C    | -    | -    | 10    | μA   |
| Drain-Source On-State Resistance                          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 4 A                                 | -    | 1.1  | -     | Ω  |
| Forward Transconductance                                  | 9 <sub>fs</sub>       |   | = 30 V, I <sub>D</sub> = 4 A                         | -    | 16   | -     | S  |
| Dynamic   |                       |   |  |      | ı.   |       |  |
| Input Capacitance   | C <sub>iss</sub>      | V <sub>GS</sub> = 0 V,  |  | -    | 860  | _     |  |
| Output Capacitance  | C <sub>oss</sub>      | 1   | $V_{DS} = 100 \text{ V},$                            | -    | 120  | -     | 1  |
| Reverse Transfer Capacitance                              | C <sub>rss</sub>      | 7   | f = 1 MHz  | -    | 15   | -     | 1  |
| Effective Output Capacitance, Energy Related <sup>a</sup> | C <sub>o(er)</sub>    | ., .,   | /. 500 V V   | -    | 45   | -     | pF   |
| Effective Output Capacitance, Time Related <sup>b</sup>   | C <sub>o(tr)</sub>    | $V_{DS} = 0.0$  | to 520 V, V <sub>GS</sub> = 0 V                      | -    | 62   | -     |  |
| Total Gate Charge   | Qg                    |   |  | -    | 25   |       |  |
| Gate-Source Charge  | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V  | $I_D = 4 A, V_{DS} = 520 V$                          | -    | 2.0  | -     | nC   |
| Gate-Drain Charge   | Q <sub>gd</sub>       | 1   |  | -    | 2.7  | -     | 1  |
| Turn-On Delay Time  | t <sub>d(on)</sub>    |   |  | -    | 25   | -     |  |
| Rise Time   | t <sub>r</sub>        | Von   | = 520 V, I <sub>D</sub> = 4 A,                       | -    | 55   | -     | ]  |
| Turn-Off Delay Time                                       | t <sub>d(off)</sub>   | 00  | = 10 V, $R_g = 9.1 \Omega$                           | -    | 70   | -     | ns   |
| Fall Time   | t <sub>f</sub>        |   |  | -    | 40   | -     |  |
| Gate Input Resistance                                     | R <sub>g</sub>        | f = 1   | MHz, open drain                                      | -    | 3.5  | -     | Ω  |
| Drain-Source Body Diode Characteristic                    | s                     |   |  |      | •    |       |  |
| Continuous Source-Drain Diode Current                     | I <sub>S</sub>        | MOSFET syml   | MOSFET symbol showing the                            |      | -    | 7     |  |
| Pulsed Diode Forward Current                              | I <sub>SM</sub>       | integral revers<br>p - n junction                                   | ₹ <del>□</del> 7                                     | -    | -    | 18    | A  |
| Diode Forward Voltage                                     | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 4 A, V <sub>GS</sub> = 0 V |  | -    | -    | 1.5   | V  |
| Reverse Recovery Time                                     | t <sub>rr</sub>       |   |  | -    | 190  | -     | ns   |
| Reverse Recovery Charge                                   | Q <sub>rr</sub>       |   | $15  ^{\circ}\text{C}$ , $I_F = I_S = 4  \text{A}$ , | -    | 2.3  | -     | μC   |
| Reverse Recovery Current                                  | I <sub>RRM</sub>      |   | 100 A/ $\mu$ s, V <sub>R</sub> = 400 V               | _    | 10   | _     | Α  |

#### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

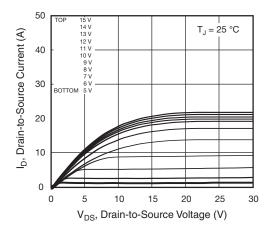


Fig. 1 - Typical Output Characteristics

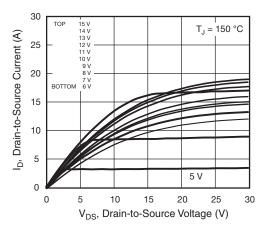


Fig. 2 - Typical Output Characteristics

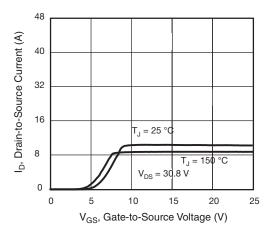


Fig. 3 - Typical Transfer Characteristics

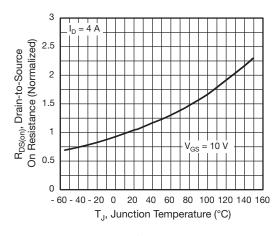


Fig. 4 - Normalized On-Resistance vs. Temperature

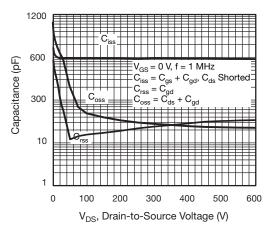


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

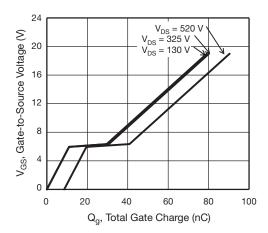


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



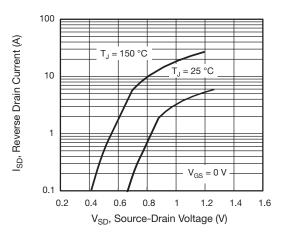


Fig. 7 - Typical Source-Drain Diode Forward Voltage

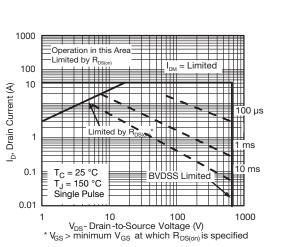


Fig. 8 - Maximum Safe Operating Area

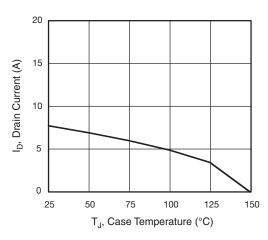


Fig. 9 - Maximum Drain Current vs. Case Temperature

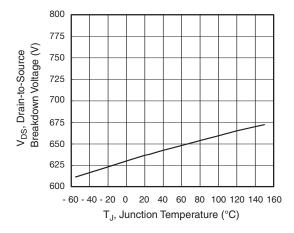


Fig. 10 - Temperature vs. Drain-to-Source Voltage

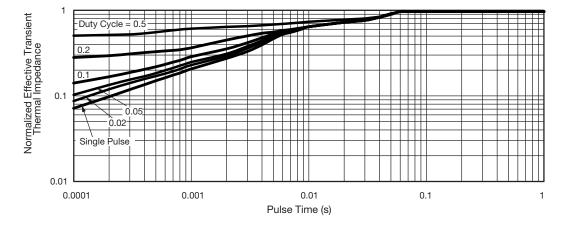


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



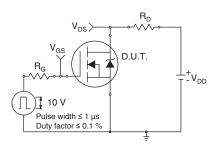


Fig. 12 - Switching Time Test Circuit

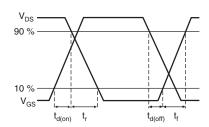


Fig. 13 - Switching Time Waveforms

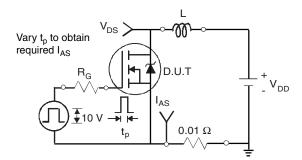


Fig. 14 - Unclamped Inductive Test Circuit

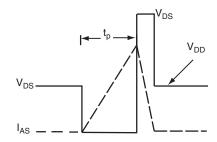


Fig. 15 - Unclamped Inductive Waveforms

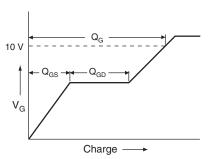


Fig. 16 - Basic Gate Charge Waveform

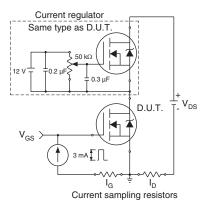
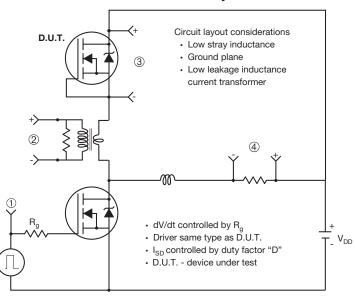


Fig. 17 - Gate Charge Test Circuit

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#### Peak Diode Recovery dV/dt Test Circuit



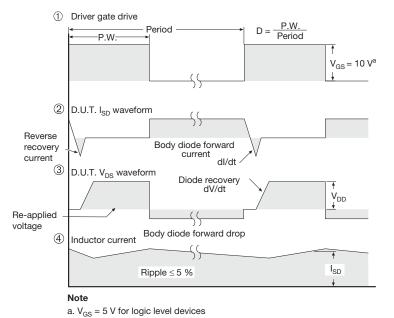
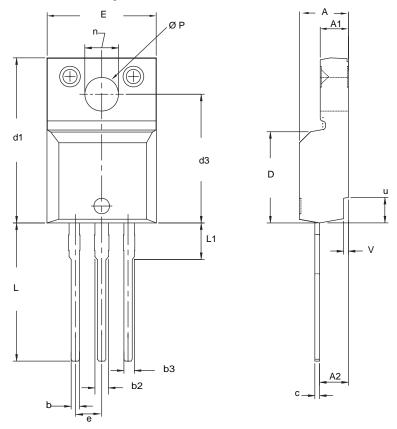


Fig. 18 - For N-Channel

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### **TO-220 FULLPAK (HIGH VOLTAGE)**



| DIM. | MIN.    |        |       |       |
|------|---------|--------|-------|-------|
|      | IVIIIV. | MAX.   | MIN.  | MAX.  |
| Α    | 4.570   | 4.830  | 0.180 | 0.190 |
| A1   | 2.570   | 2.830  | 0.101 | 0.111 |
| A2   | 2.510   | 2.850  | 0.099 | 0.112 |
| b    | 0.622   | 0.890  | 0.024 | 0.035 |
| b2   | 1.229   | 1.400  | 0.048 | 0.055 |
| b3   | 1.229   | 1.400  | 0.048 | 0.055 |
| С    | 0.440   | 0.629  | 0.017 | 0.025 |
| D    | 8.650   | 9.800  | 0.341 | 0.386 |
| d1   | 15.88   | 16.120 | 0.622 | 0.635 |
| d3   | 12.300  | 12.920 | 0.484 | 0.509 |
| E    | 10.360  | 10.630 | 0.408 | 0.419 |
| е    | 2.54    | BSC    | 0.100 | BSC   |
| L    | 13.200  | 13.730 | 0.520 | 0.541 |
| L1   | 3.100   | 3.500  | 0.122 | 0.138 |
| n    | 6.050   | 6.150  | 0.238 | 0.242 |
| ØΡ   | 3.050   | 3.450  | 0.120 | 0.136 |
| u    | 2.400   | 2.500  | 0.094 | 0.098 |
| V    | 0.400   | 0.500  | 0.016 | 0.020 |

#### Notes

- To be used only for process drawing.
  These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
  All critical dimensions should C meet C<sub>pk</sub> > 1.33.
  All dimensions include burrs and plating thickness.

- 5. No chipping or package damage.



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